

CMOS 4-BIT MICROCONTROLLER

TMP47P800N TMP47P800F

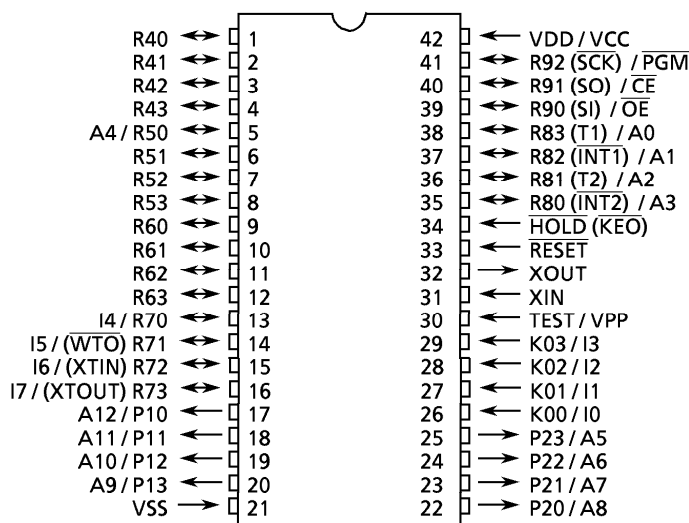
The 47P800 is the system evaluation LSI of 47C800 with 64K bits one-time PROM. The 47P800 programs / verifies using an adapter socket to connect with PROM programmer, as it is in TMM2764D.

In addition, the 47P800 and the 47C800 are pin compatible. The 47P800 operates as the same as the 47C800 by programming to the internal PROM.

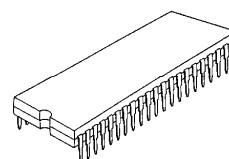
PART No.	ROM	RAM	PACKAGE	ADAPTER SOCKET
TMP47P800N	OTP	512 × 4-bit	SDIP42-P-600-1.78	BM1108
TMP47P800F	8192 × 8-bit		QFP44-P-1414-0.80D	BM1111

PIN ASSIGNMENT (TOP VIEW)

SDIP42-P-600-1.78



SDIP42-P-600-1.78



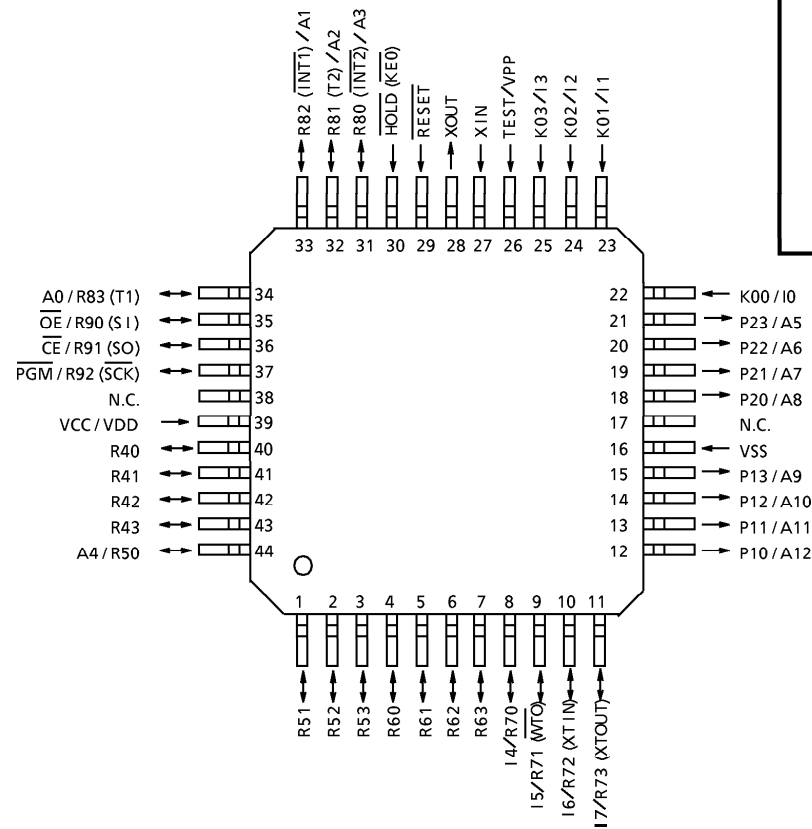
TMP47P800N

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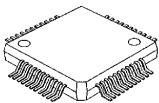
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PIN ASSIGNMENT (TOP VIEW)

QFP44-P-1414-0.80D



QFP44-P-1414-0.80D



TMP47P800F

PIN FUNCTION

The 47P800 has MCU mode and PROM mode.

(1) MCU mode

The 47C800 and the 47P800 are pin compatible (TEST pin for out-going test. Be fixed to low level).

(2) PROM mode

PIN NAME	Input/Output	FUNCTIONS	PIN NAME (MCU MODE)
A12 to A9	Input	Address inputs	P10 to P13
A8 to A5			P20 to P23
A4			R50
A3 to A0			R80 to R83
I7 to I4	I/O	Data inputs / outputs	R73 to R70
I3 to I0			K03 to K00
$\overline{\text{PGM}}$	Input	Program control input	R92
$\overline{\text{CE}}$		Chip Enable input	R91
$\overline{\text{OE}}$		Output Enable input	R90
VPP	Power supply	+ 21V / 5V (Program supply voltage)	TEST
VCC		+ 5V	VDD
VSS		0V	VSS
R53 to R51	I/O	Be fixed to low level.	
R63 to R60			
R43, R42			
R41, R40			
$\overline{\text{RESET}}$	Input	PROM mode setting pins. Be fixed to low level.	
$\overline{\text{HOLD}}$	Input		
XIN	Input	Resonator connecting pins	
XOUT	Output		

OPERATIONAL DESCRIPTION

The following is an explanation of hardware configuration and operation in relation to the 47P800. The 47P800 is the same as the 47C800 except that an OTP is used instead of a built-in Mask ROM.

1. OPERATION MODE

The 47P800 has an MCU mode and PROM mode.

1.1 MCU mode

The MCU mode is set by fixing the TEST / VPP pin at the "L" level. Operation in the MCU Mode is the same as for the 47C800 except that the TEST / VPP pin does not have pull-down resistor and can not be used open.

1.1.1 Program memory

The program storage area is the same as for the 47C800.

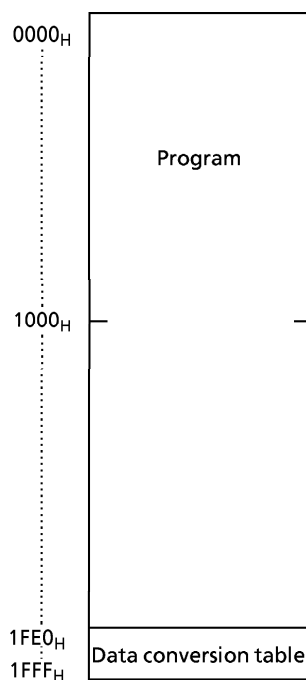


Figure 1-1. Program area

1.1.2 Data memory

The 47P800 has 256X4 bits data memory bank (RAM).

1.1.3 Input /Output Circuitry

(1) Control pins

This is the same as for the 47C800 except that there is no pull-down resistor for the TEST pin.

(2) I/O ports

The input / output circuit of the 47C800 is the same as I/O code RA of the 47C800 external resistor, for example, is required when using as evaluator of other I/O codes (RB to RF) (Refer to Figure 1-2).

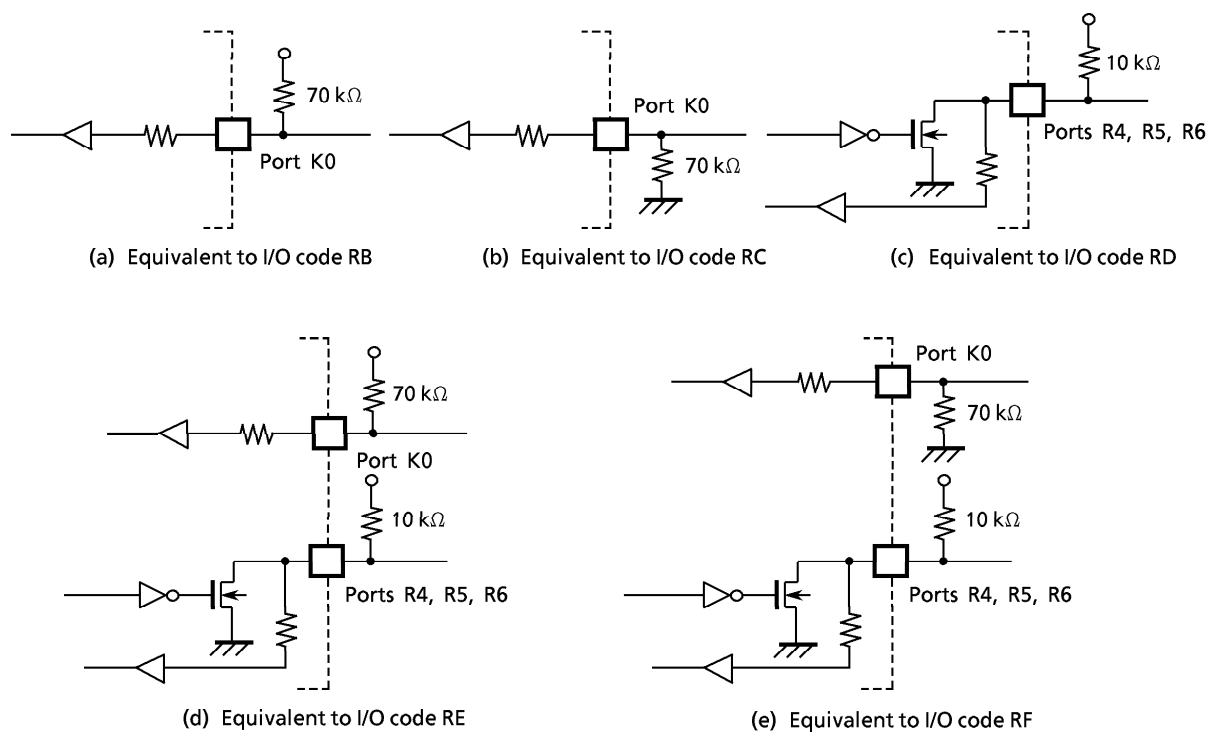
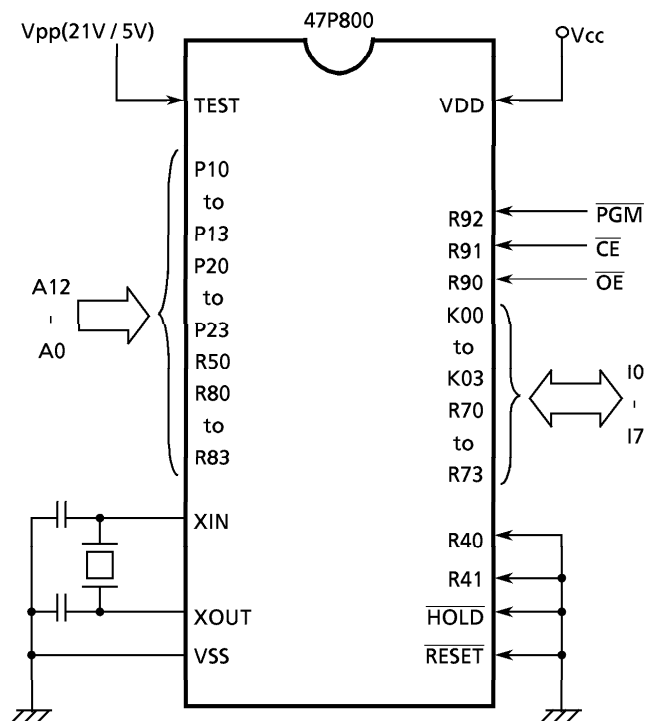


Figure 1-2. I/O code and external circuitry

1.2 PROM mode

The PROM mode is set by setting the $\overline{\text{RESET}}$, $\overline{\text{HOLD}}$, K00 and K01 pins to the "L" level. The PROM mode can be used as a general-purpose PROM writer for program writing and verification (A high-speed program mode is used set the ROM type the same as for the TMM2764D).



For more information on pins refer to the section on pin function.

Figure 1-3. Setting for PROM mode

1.2.1 High Speed Programming Mode

The device is set up in the high speed programming mode when the programming voltage (21.0V) is applied to the VPP pin with $V_{CC} = 6V$ and $\overline{PGM} = V_{IH4}$. The programming is achieved by applying a single TTL low level 1 msec pulse the $\overline{PGM}$ input after addresses and data are stable. Then the programmed data is verified by using program Verify Mode. If the programmed data is not correct, another program pulse of 1 msec is applied and then programmed data is verified. This should be repeated until the program operates correctly (max. 15 times). After correctly programming the selected address, one additional program pulse with pulse width 4 times that needed for programming is applied. When programming has been completed, the data in all addresses should be verified with $V_{CC} = V_{pp} = 5V$.

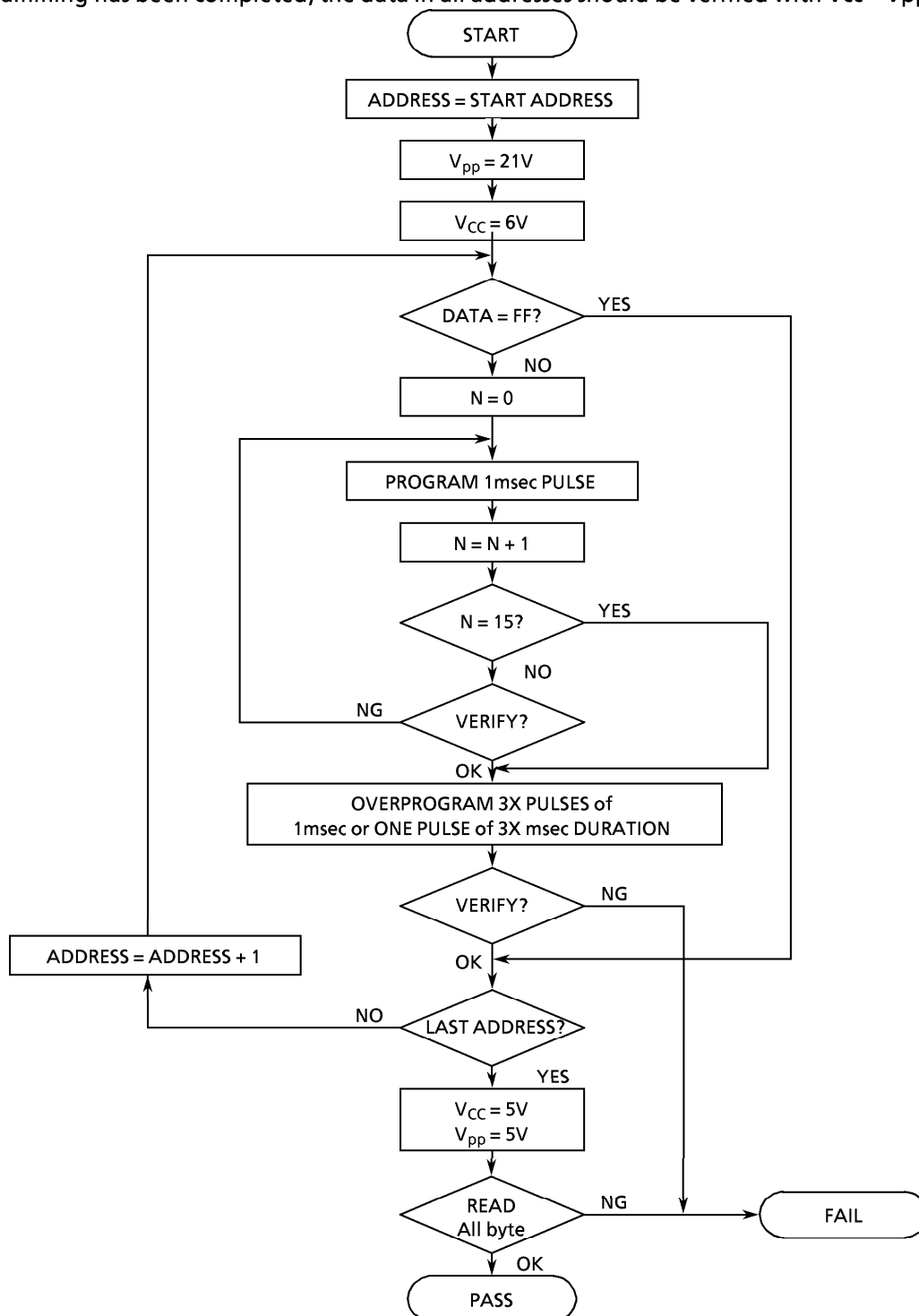


Figure1-4. FLOW CHART

ELECTRICAL CHARACTERISTICS

ABSOLUTE MAXIMUM RATINGS

(V_{SS} = 0V)

PARAMETER	SYMBOL	PINS	RATINGS	UNIT
Supply Voltage	V _{DD}		– 0.3 to 7	V
Input Voltage	V _{IN}		– 0.3 to V _{DD} + 0.3	V
Output Voltage	V _{OUT1}	Except the sink open drain pin, but include R7	– 0.3 to V _{DD} + 0.3	V
	V _{OUT2}	The sink open drain pin except R7	– 0.3 to 10	
Output Current (Per 1 pin)	I _{OUT1}	Ports R	3.2	mA
	I _{OUT2}	Ports P1, P2	30	
Output Current (Total)	ΣI _{OUT1}	Ports P1, P2	120	mA
Power Dissipation [T _{opr} = 70°C]	PD		600	mW
Soldering Temperature (time)	T _{sld}		260 (10 s)	°C
Storage Temperature	T _{stg}		– 55 to 125	°C
Operating Temperature	T _{opr}		– 40 to 70	°C

RECOMMENDED OPERATING CONDITIONS

(V_{SS} = 0V, T_{opr} = – 40 to 70°C)

PARAMETER	SYMBOL	PINS	CONDITIONS	Min.	Max.	UNIT
Supply Voltage	V _{DD}		in the Normal operating mode	4.5	6.0	V
			in the SLOW operating mode	2.7		
			in the HOLD operating mode	2.0		
High Input Voltage	V _{IH1}	Except Hysteresis Input	V _{DD} ≥ 4.5V	V _{DD} × 0.7	V _{DD}	V
	V _{IH2}	Hysteresis Input		V _{DD} × 0.75		
	V _{IH3}		V _{DD} < 4.5V	V _{DD} × 0.9		
Low Input Voltage	V _{IL1}	Except Hysteresis Input	V _{DD} ≥ 4.5V	0	V _{DD} × 0.3	V
	V _{IL2}	Hysteresis Input			V _{DD} × 0.25	
	V _{IL3}		V _{DD} < 4.5V		V _{DD} × 0.1	
Clock Frequency	f _c	XIN, XOUT		0.4	6.0	MHz
	f _s	XTIN, XTOUT		30.0	34.0	kHz

Note. Input voltage V_{IH3}, V_{IL3} : in the SLOW or HOLD operation.

D.C. CHARACTERISTICS

(V_{SS} = 0V, T_{opr} = -40 to 70°C)

PARAMETER	SYMBOL	PINS	CONDITIONS	Min.	Typ.	Max.	UNIT
Hysteresis Voltage	V _{HS}	Hysteresis input		—	0.7	—	V
Input Current	I _{IN1}	Port K0, TEST, RESET, HOLD	V _{DD} = 5.5V	—	—	± 2	μA
	I _{IN2}	Ports R (open-drain)	V _{IN} = 5.5V / 0V				
Input Resistance	R _{IN2}	RESET		100	220	450	kΩ
Output Leakage Current	I _{LO}	Ports R, P (open drain)	V _{DD} = 5.5V, V _{OUT} = 5.5V	—	—	2	μA
Output Low Voltage	V _{OL2}	Except XOUT XTOUT, Ports P1, P2	V _{DD} = 4.5V, I _{OL} = 1.6 mA	—	—	0.4	V
Low Level Output Current	I _{OL1}	Ports P1, P2	V _{DD} = 4.5V, V _{OL} = 1.0V	—	20	—	mA
Supply Current (in the Nomal mode)	I _{DD}		V _{DD} = 5.5V f _c = 4 MHz	—	5	10	mA
Supply Current (in the SLOW mode)	I _{DDS}		V _{DD} = 5.0V f _s = 32.768 kHz	—	5	8	mA
Supply Current (in the HOLD mode)	I _{DDH}		V _{DD} = 5.5V	—	0.5	10	μA

Note 1. Typ. values show those at T_{opr} = 25°C, V_{DD} = 5V.

Note 2. Input Current I_{IN1} ; The current through resistor is not included, when the input resistor (pull-up/pull-down) is contained.

Note 3. Supply Current I_{DD}, I_{DDH} ; V_{IN} = 5.3V/0.2V

The K0 port is opened when the input resistor is contained. The voltage applied to the R port is within the valid range.

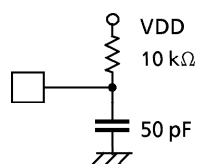
Supply Current I_{DDS} ; V_{IN} = 2.8V/0.2V, low frequency clock is only oscillated (connecting XTIN, XTOUT).

A.C. CHARACTERISTICS ($V_{SS} = 0V$, $V_{DD} = 4.5$ to $6.0V$, $T_{opr} = -40$ to $70^{\circ}C$)

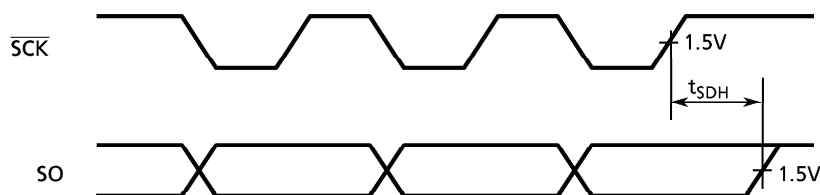
PARAMETER	SYMBOL	CONDITION	Min.	Typ.	Max.	UNIT
Instruction Cycle Time	t_{cy}	in the Normal mode	1.33	—	20	μs
		in the SLOW mode	235	—	267	
High level Clock Pulse Width	t_{WCH}	For external clock operation	80	—	—	ns
Low level Clock Pulse Width	t_{WCL}					
Shift Data Hold Time	t_{SDH}		$0.5t_{cy} - 300$	—	—	ns

Note. Shift Data Hold Time:

External circuit for $\overline{SCK}$ pin and SO pin



Serial port (completion of transmission)

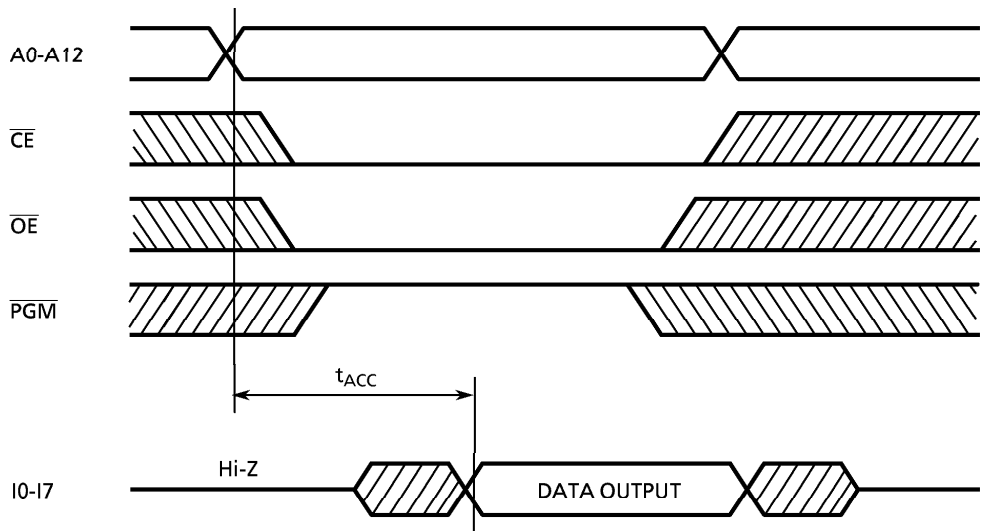

RECOMMENDED OSCILLATING CONDITIONS ($V_{SS} = 0V$, $V_{DD} = 4.5$ to $6.0V$, $T_{opr} = -40$ to $70^{\circ}C$)

Recommended oscillating conditions of the 47P800 are equal to the 47C800's.

D.C. / A.C. CHARACTERISTICS (PROM mode) ($V_{SS} = 0V$)

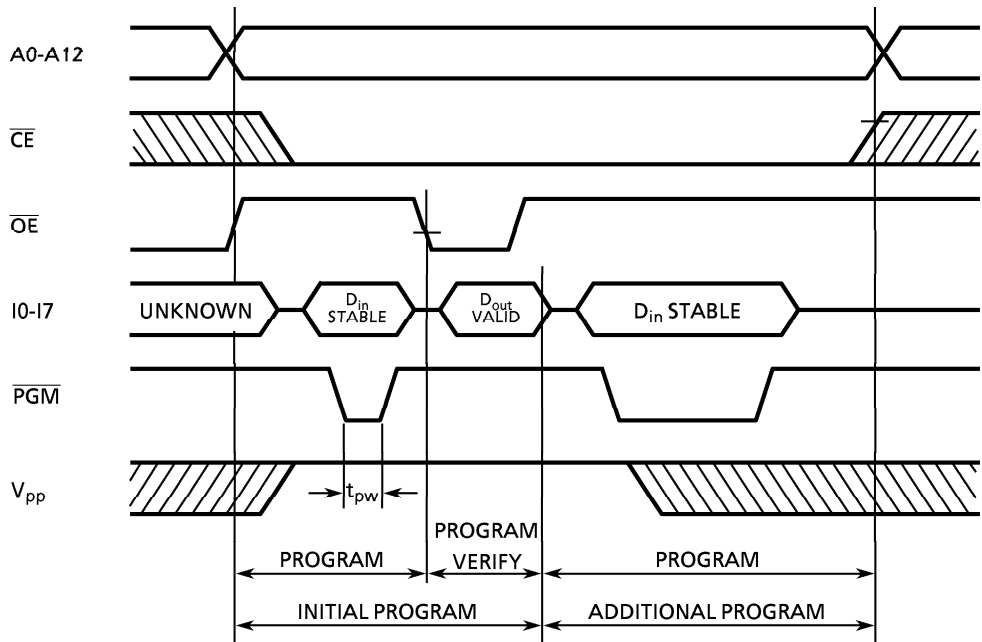
(1) Read Operation

PARAMETER	SYMBOL	CONDITION	Min.	Typ.	Max.	UNIT
Output Level High Voltage	V_{IH4}		$V_{CC} \times 0.7$	—	V_{CC}	V
Output Level Low Voltage	V_{IL4}		0	—	$V_{CC} \times 0.12$	V
Supply Voltage	V_{CC}		4.75	—	6.0	V
Programming Voltage	V_{PP}					
Address Access Time	t_{ACC}	$V_{CC} = 5.0 \pm 0.25V$	0	—	350	ns



(2) High Speed Programming Operation

PARAMETER	SYMBOL	CONDITION	Min.	Typ.	Max.	UNIT
Input High Voltage	V_{IH4}		$V_{CC} \times 0.7$	–	V_{CC}	V
Input Low Voltage	V_{IL4}		0	–	$V_{CC} \times 0.12$	V
Supply Voltage	V_{CC}		4.75	–	6.0	V
V_{PP} Power Supply Voltage	V_{PP}		20.5	21.0	21.5	V
Programming Pulse Width	t_{PW}	$V_{CC} = 6.0 \pm 0.25V$	0.95	1.0	1.05	ms



※ Difference compared with the 47C800
The 47P800 is different from the 47C800 with respect to the following spec points.

PARAMETER	SYMBOL	CONDITION	47C800			47P800			UNIT
			Min.	Typ.	Max.	Min.	Typ.	Max.	
Supply Voltage	V_{DD}	in the NORMAL operation	4.5	—	6.0	4.5	—	6.0	V
		in the SLOW operation	2.7	—					
Supply Current	I_{DD}	in the NORMAL operation	—	3	6	—	5	10	mA
	I_{DDS}	in the SLOW operation	—	$30\mu\text{A}$ ($V_{DD} = 3\text{V}$)	$60\mu\text{A}$ ($V_{DD} = 3\text{V}$)	—	5mA ($V_{DD} = 5\text{V}$)	8mA ($V_{DD} = 5\text{V}$)	—

Note. Be fixed low level at MCU mode because of TEST pin does not have pull-down resistor.

TYPICAL CHARACTERISTICS

